


Search Notes 	Application/Control No. 10500562	Applicant(s)/Patent Under Reexamination KAMEI, TOSHIO
	Examiner Yeh, Eueng-nan	Art Unit 2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(382/173) text search - see search outputs	2007/12/31	ey
EAST text search - see search outputs	2007/12/27	ey
PALM inventor search - see search outputs	2007/12/27	ey
IEEE Xplore search - see search outputs	2008/01/02	ey

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